

Notice of References Cited	Application/Control No. 10/822,023		Applicant(s)/Patent Under Reexamination CHURT ET AL.	
	Examiner David Q. Nguyen		Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0184448	10-2003	Kagan, Erran	340/870.28
*	B	US-2004/0087273	05-2004	Perttola et al.	455/041.2
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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